



Fluorescence Profile Monitor for the CERN e-Lens

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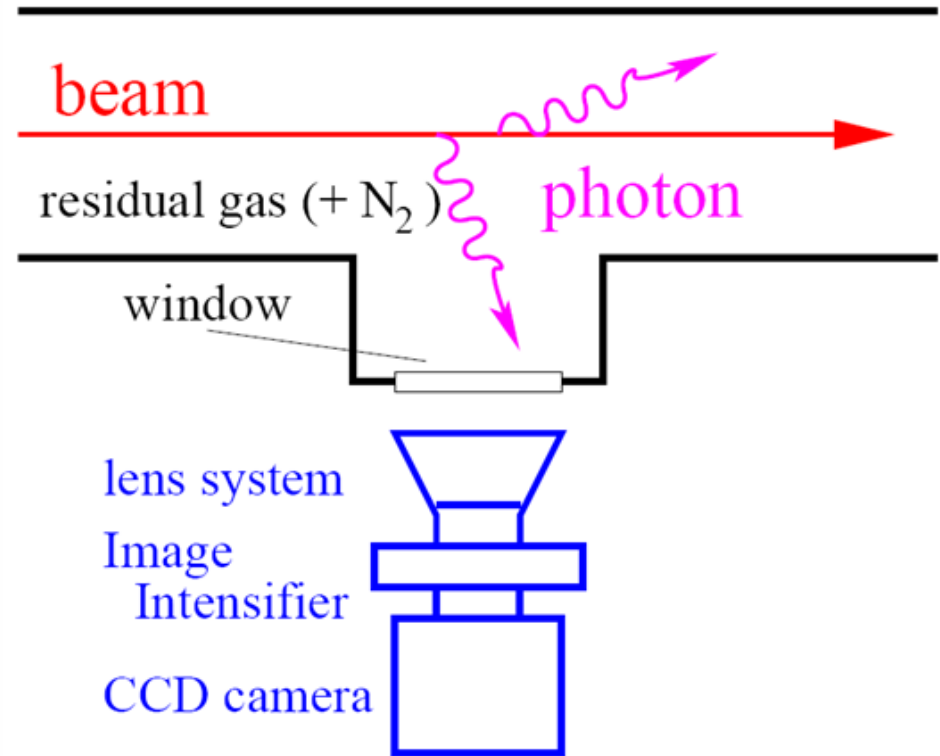


- Beam Induced Fluorescence (BIF) working principle and features
- Characteristics of the CERN e-lens setup
- N_2 as working gas
- Ion and electron dynamics
- Ne as working gas
- Optics
- Open questions
- Conclusions

Beam Induced Fluorescence Features @ GSI



- Based upon the detection of photons emitted by residual or injected (low pressure) gas molecules
- Little influence on the beam
- Single pulse observation possible; down to $\approx 1 \mu\text{s}$ time resolution
- High resolution, e.g. 0.2 mm/pixel, can be easily matched to application
- Commercial image intensifier available
- Compact installation, e.g. 25 cm for both planes



Intensified CCD working principle

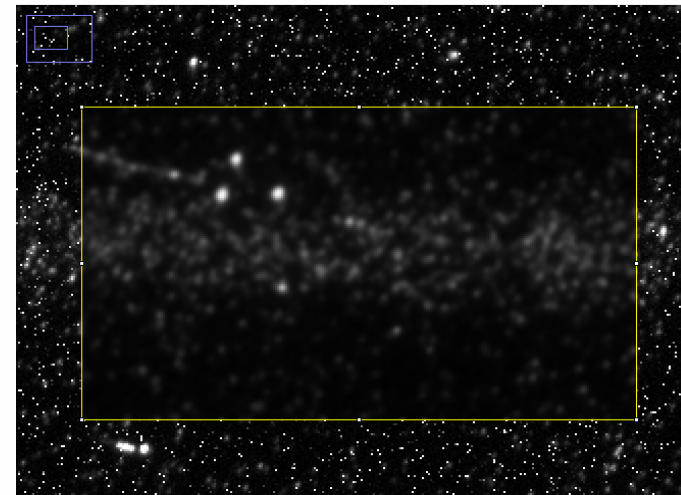
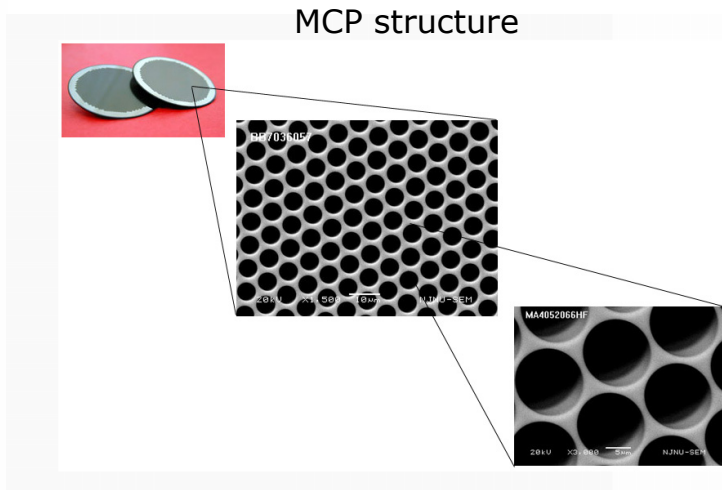
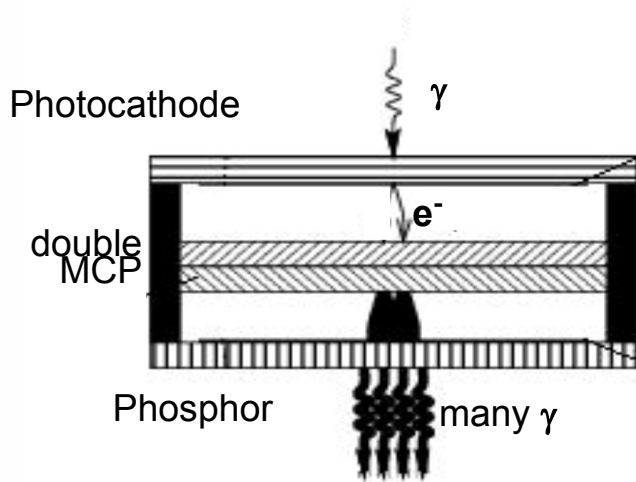


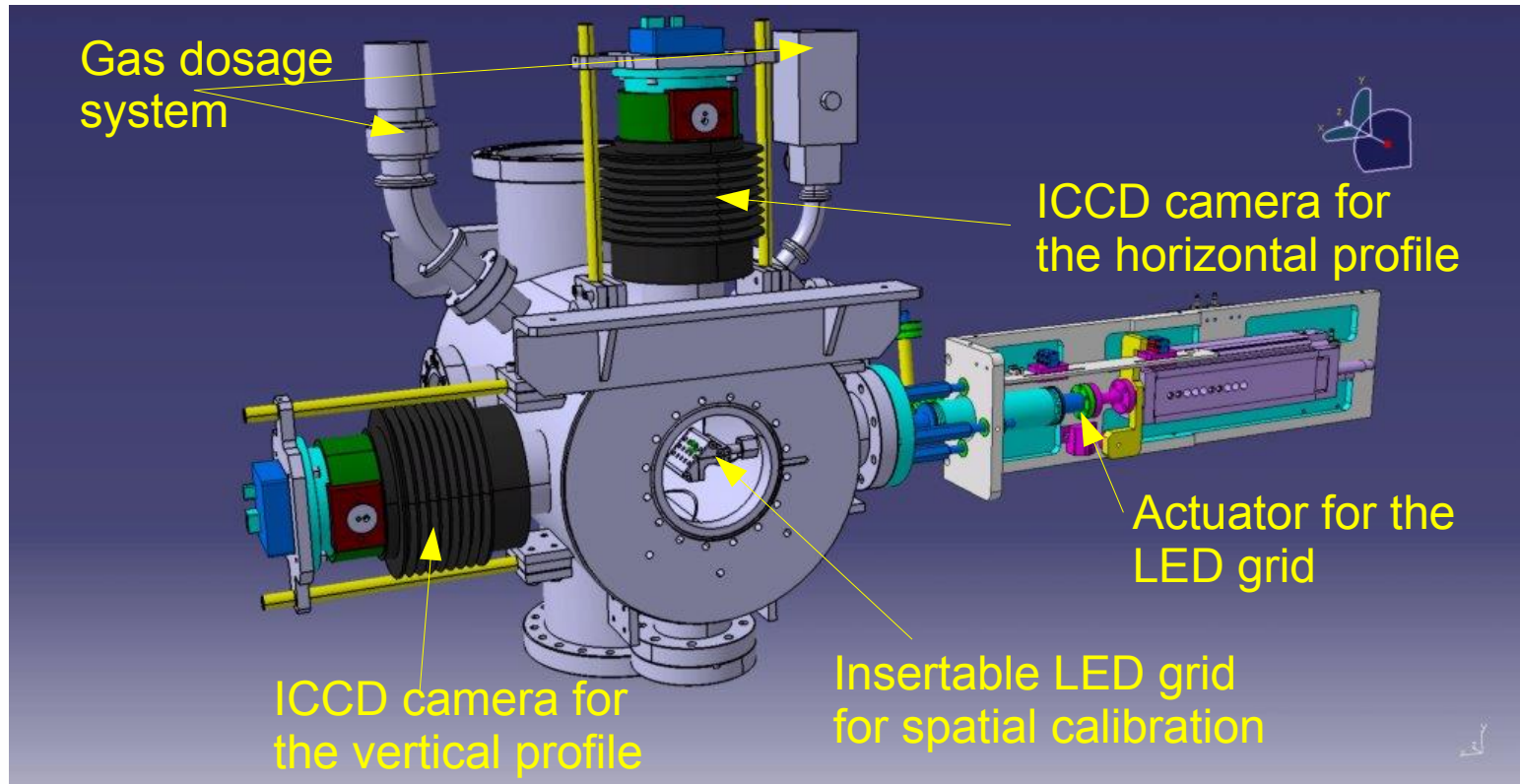
Image from $5 \cdot 10^8$, 300 MeV/u $^{238}\text{U}^{73+}$ ions in N_2 , $p = 5 \cdot 10^{-3}$ mbar.

BIF-Monitors at the GSI UNILAC

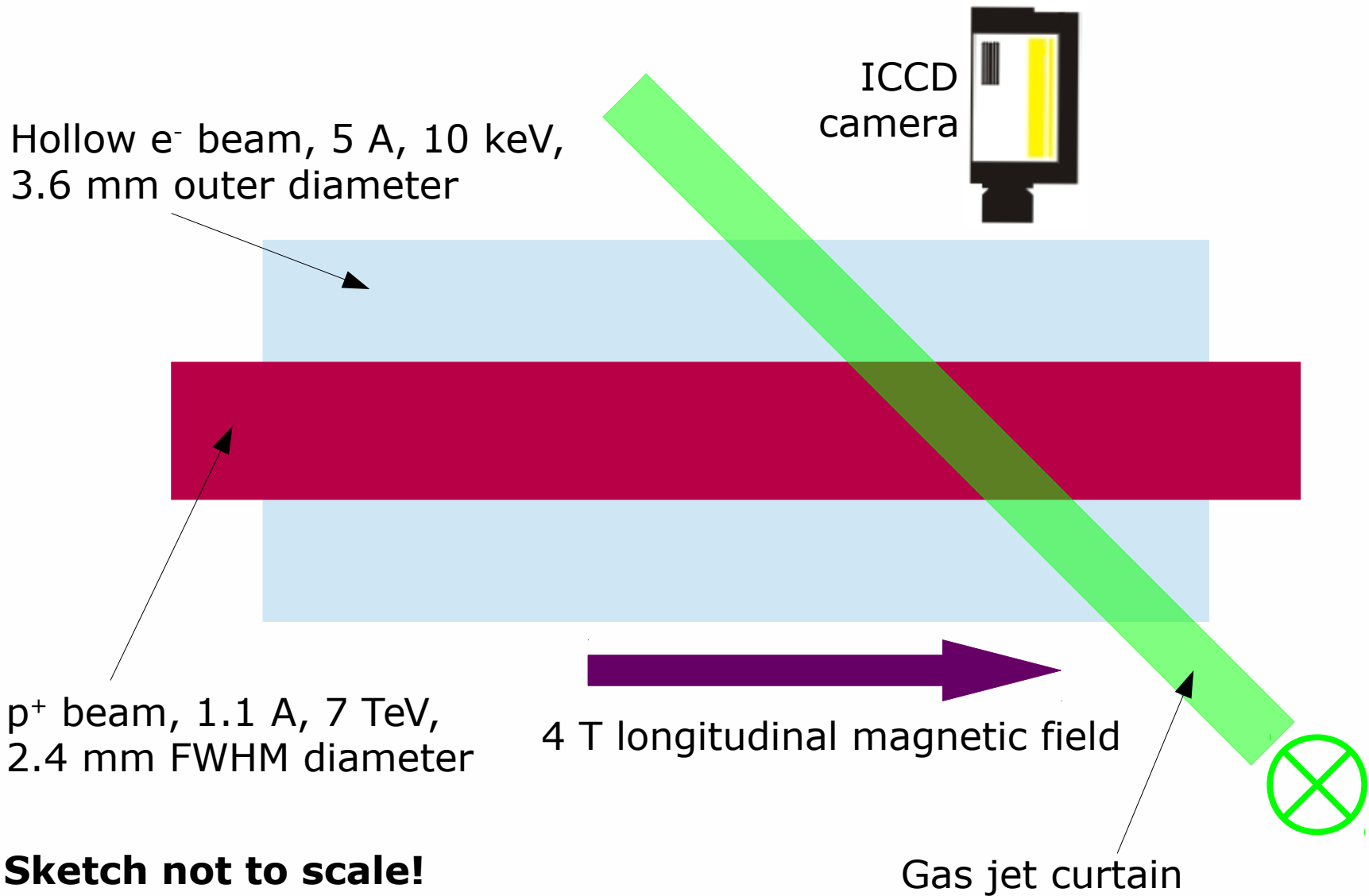


Six BIF stations at the GSI LINAC:

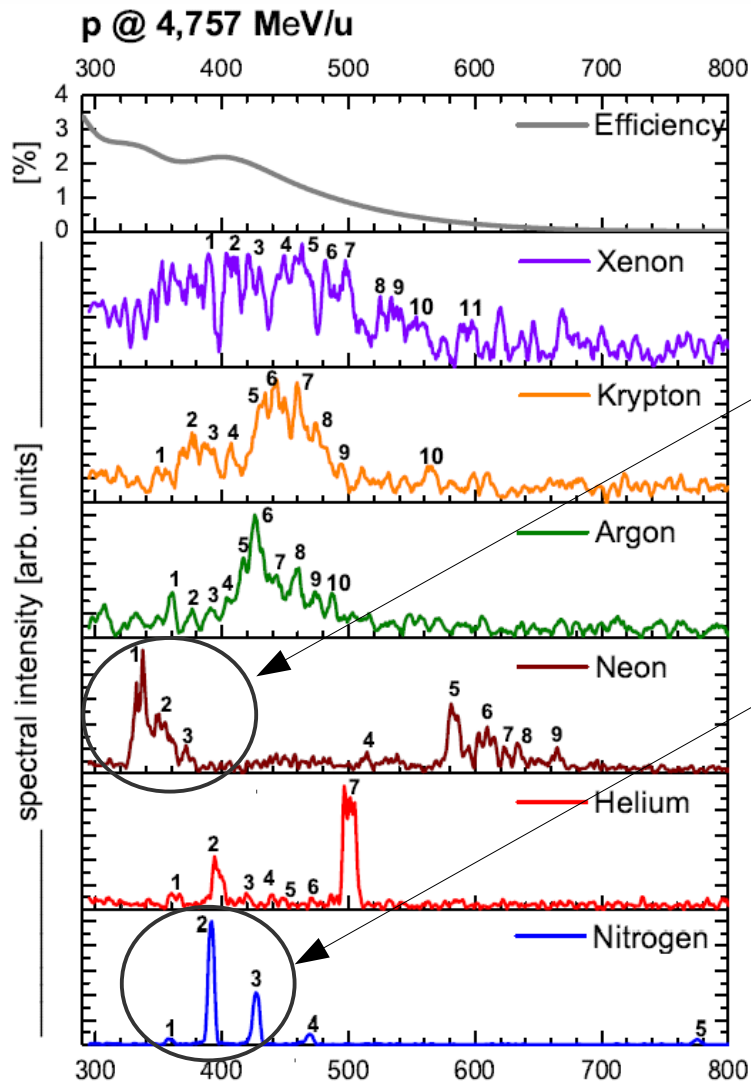
- 2 x image intensified CCD cameras each
- Optics with reproduction scale 0.2 mm/pixel
- Insertion length 25 cm for both directions only
- Single macro-pulse observation



E-Lens and BIF @ CERN



Fluorescence of different gases



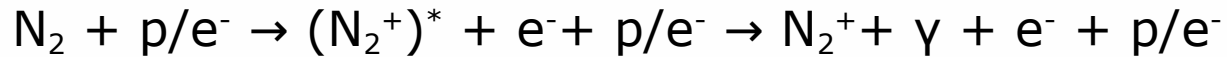
Several Ne⁺ lines mainly corresponding to different $[2s^22p^4(^3P)]3p \rightarrow 3s$ transitions and with life times below 10 ns.

The strong lines correspond to the $B^2\Sigma_u^+ \rightarrow X^2\Sigma_g^+$ electronic transition band of N₂⁺, life times are of about 60 ns.

Note: Nitrogen has a higher photon yield than noble gases; scaling intensity by energy loss results in an almost constant value for noble gases.

F. Becker, Ph.D. thesis, T.U. Darmstadt, Germany, 2009

N₂ as working gas: excitation and emission



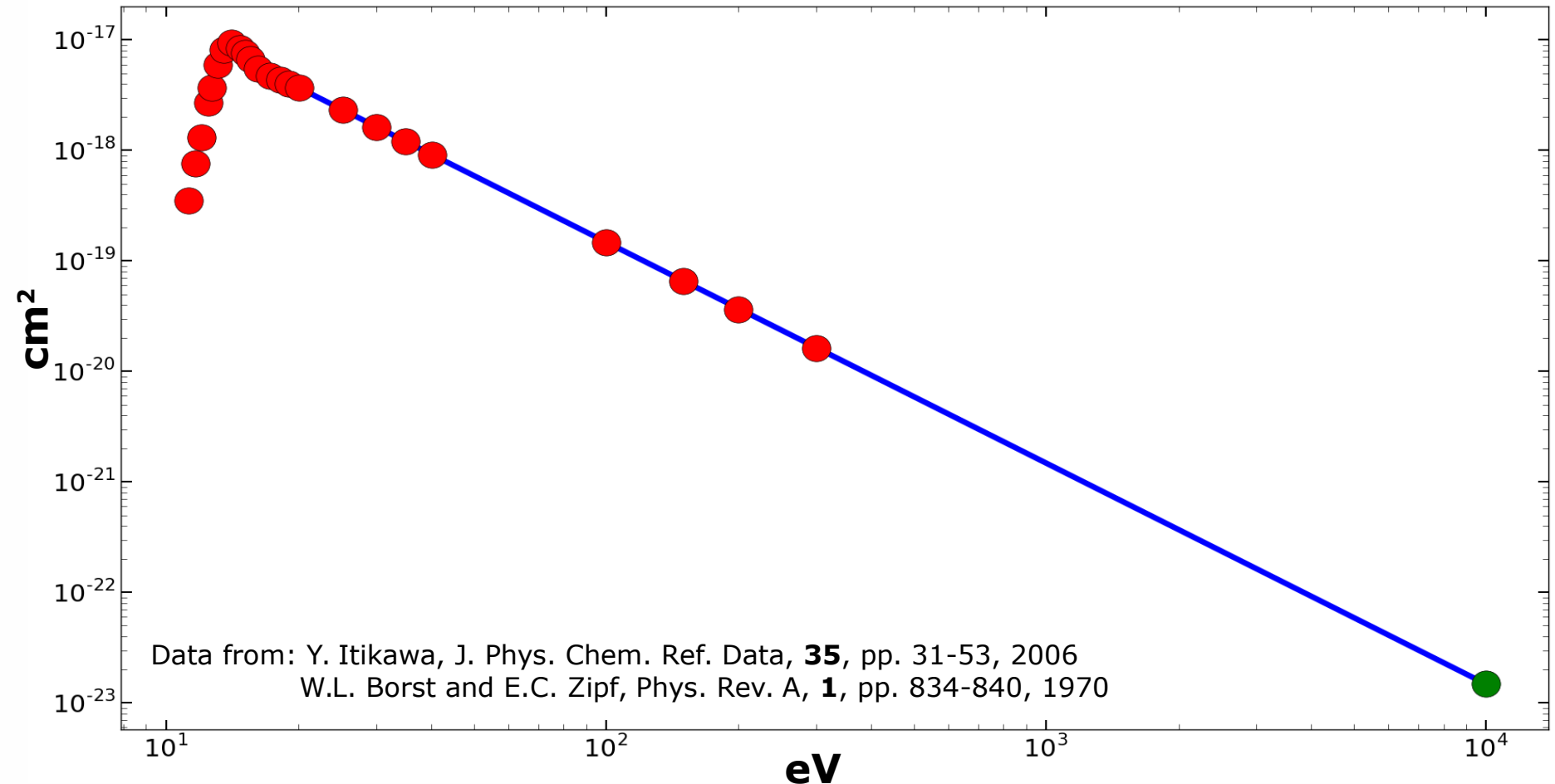
Leads to the electronic transition $\text{B}^2\Sigma_u^+ \rightarrow \text{X}^2\Sigma_g^+$ of the molecular ion with wavelengths around 391 nm, depending upon involved vibrational and rotational states



Drives the electronic transition $\text{C}^3\Pi_u \rightarrow \text{B}^3\Pi_g$ of the neutral molecule with wavelengths around 337 nm. This process cannot be initiated directly by protons.

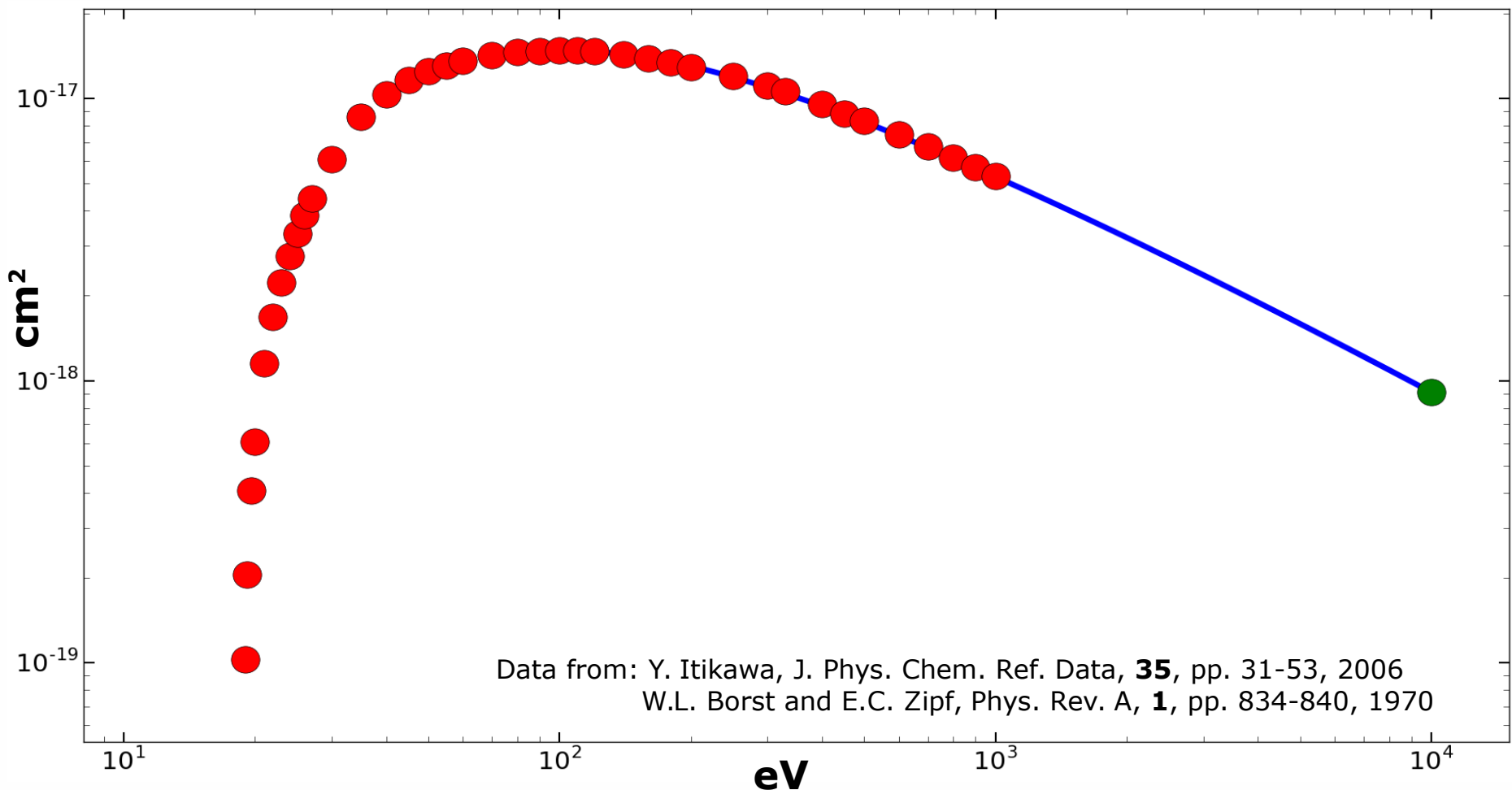
Note: Ionization is relevant too, due to the generation of secondary low energy electrons with high cross sections for excitation and/or ionization of N₂.

N_2 as working gas: $C^3\Pi_u \rightarrow B^3\Pi_g$ cross section for e^-



$$\sigma_{337}^e \approx 1.48 \cdot 10^{-15} \cdot E^{-2} \text{ cm}^2 = 1.48 \cdot 10^{-23} \text{ cm}^2 @ 10 \text{ keV}$$

N₂ as working gas: B²Σ_u⁺ → X²Σ_g⁺ cross section for e⁻



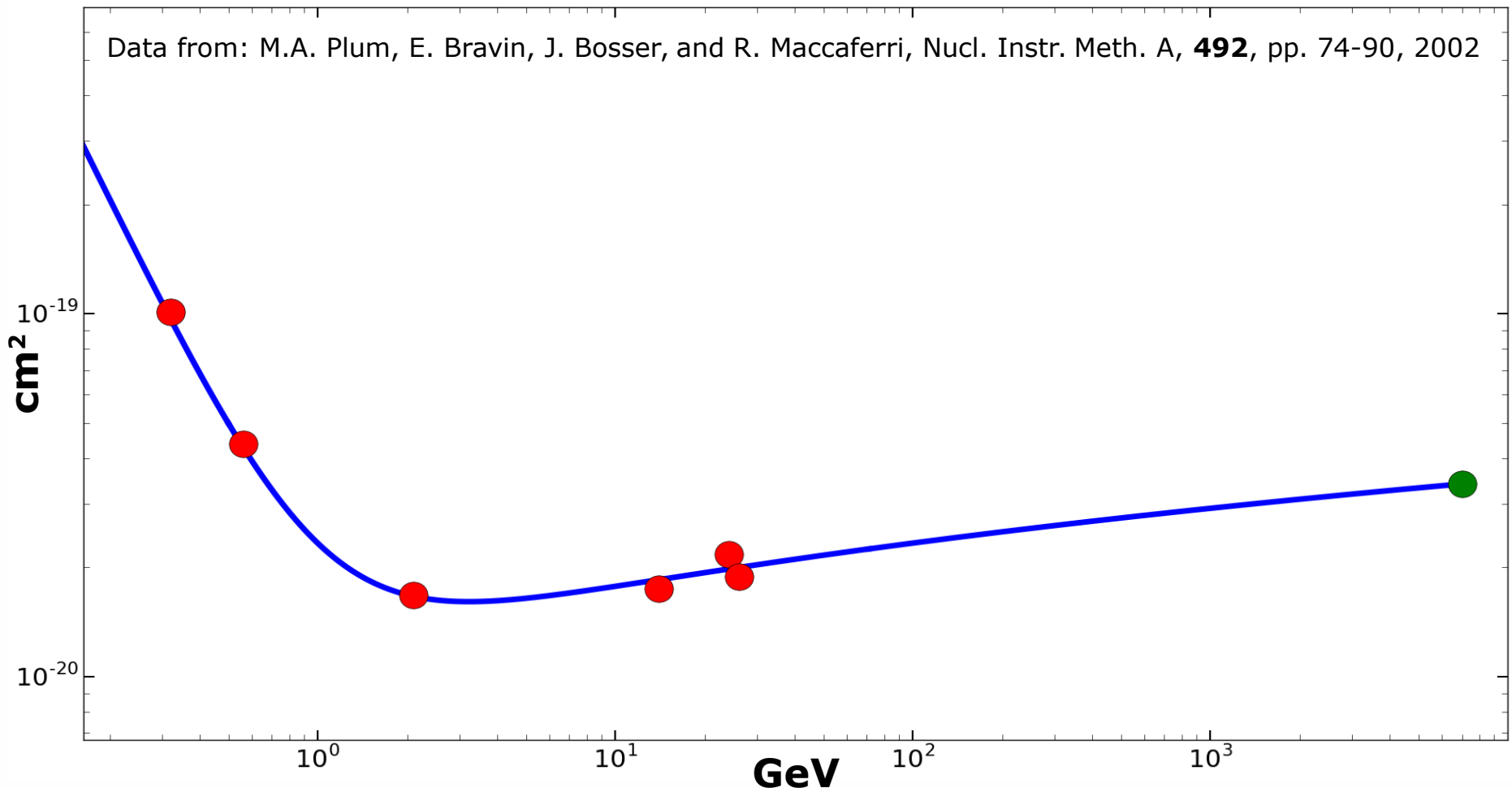
Data from: Y. Itikawa, J. Phys. Chem. Ref. Data, **35**, pp. 31-53, 2006
W.L. Borst and E.C. Zipf, Phys. Rev. A, **1**, pp. 834-840, 1970

$$\sigma_{391}^e \approx \frac{1.66 \cdot 10^{-15}}{E} \cdot \ln(2.4 \cdot 10^{-2} \cdot E) \text{ cm}^2 = 9.1 \cdot 10^{-19} \text{ cm}^2 @ 10 \text{ keV}$$

N₂ as working gas: B²Σ_u⁺ → X²Σ_g⁺ cross section for p⁺

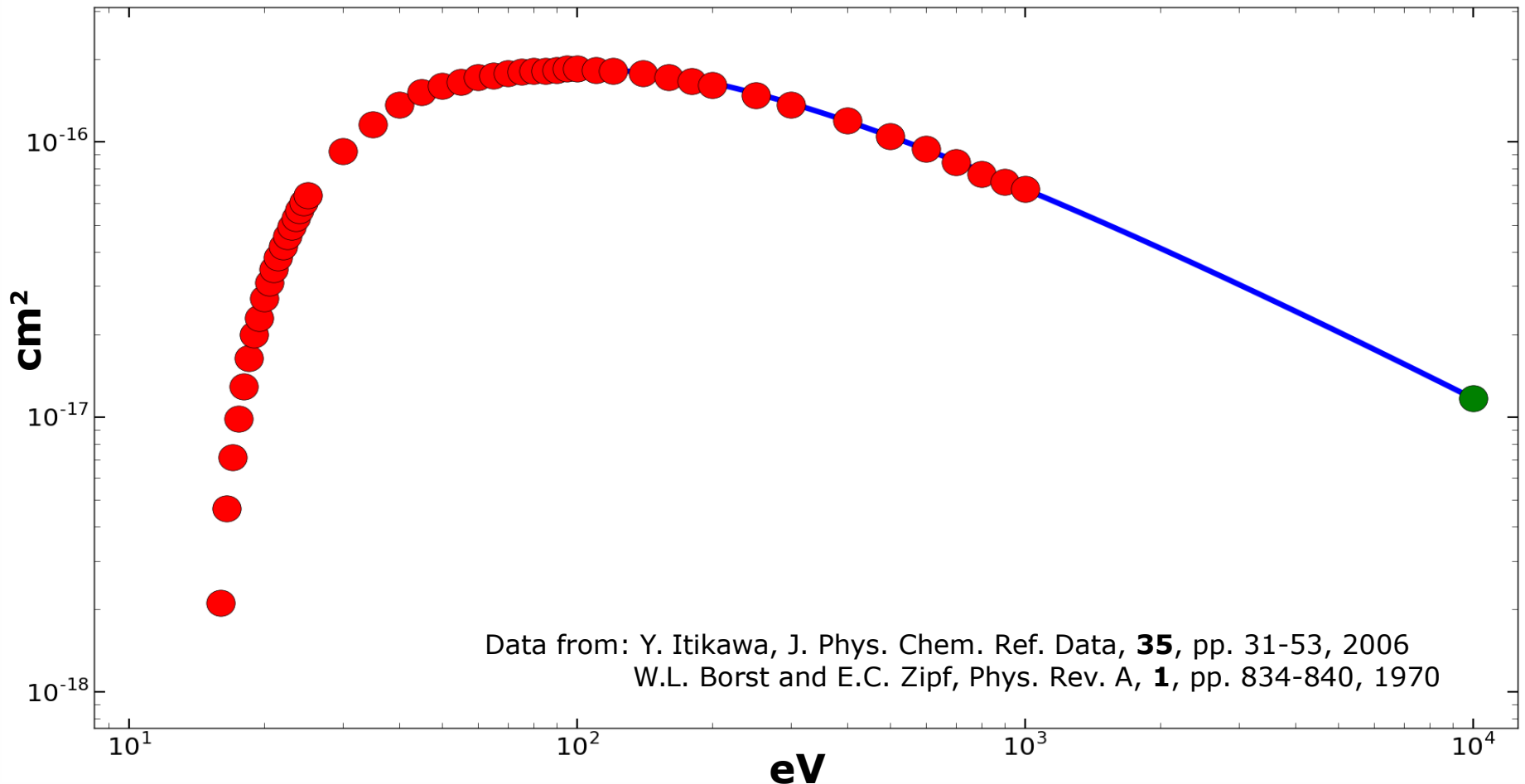


Data from: M.A. Plum, E. Bravin, J. Bosser, and R. Maccaferri, Nucl. Instr. Meth. A, **492**, pp. 74-90, 2002



$$\sigma_{391}^p \approx 1.3 \cdot 10^{-21} \cdot \left[\left(1 + \left(\frac{0.94}{p \cdot c} \right)^2 \right) \cdot \left(2 \cdot \ln \left(\frac{p \cdot c}{0.94} \right) + 10.3 \right) - 1 \right] \text{cm}^2 = 3.4 \cdot 10^{-20} \text{cm}^2 @ 10 \text{keV}$$

N₂ as working gas: ionization cross section for e⁻



$$\sigma_{\text{ion}}^e \approx \frac{2.15 \cdot 10^{-14}}{E} \cdot \ln(2.3 \cdot 10^{-2} \cdot E) \text{ cm}^2 = 1.2 \cdot 10^{-17} \text{ cm}^2 @ 10 \text{ keV}$$

N_2 as working gas: detected photons



$$N_y = \sigma \cdot \frac{I \cdot \Delta t}{e} \cdot n \cdot d \cdot \frac{\Omega}{4\pi} \cdot T \cdot T_f \cdot \eta_{pc} \cdot \eta_{MCP}$$

N_y = average number of photons detected during time Δt

σ = cross section of the photon generation process

I = electron or proton current (electrical)

E = elementary charge

n = gas density

d = distance traveled through gas (curtain thickness)

Ω = solid angle of the optics

T = transmittance of the optical system

T_f = transmittance of the optical filter

η_{pc} = quantum efficiency of the photocathode

η_{MCP} = detection efficiency of the MCP

N_2 as working gas: specific detection time



$$N_\gamma = \sigma \cdot \frac{I \cdot \Delta t}{e} \cdot n \cdot d \cdot \frac{\Omega}{4\pi} \cdot T \cdot T_f \cdot \eta_{pc} \cdot \eta_{MCP}$$

$$I = 1 \text{ A}$$

$$n = 2.5 \cdot 10^{10} \text{ cm}^{-3}$$

$$d = 5 \cdot 10^{-2} \text{ cm}$$

$$\Omega = 4\pi \cdot 10^{-5} \text{ sr}$$

$$T = 65\%$$

$$T_f = 30\%$$

$$\eta_{pc} = 20\%$$

$$\eta_{MCP} = 50\%$$

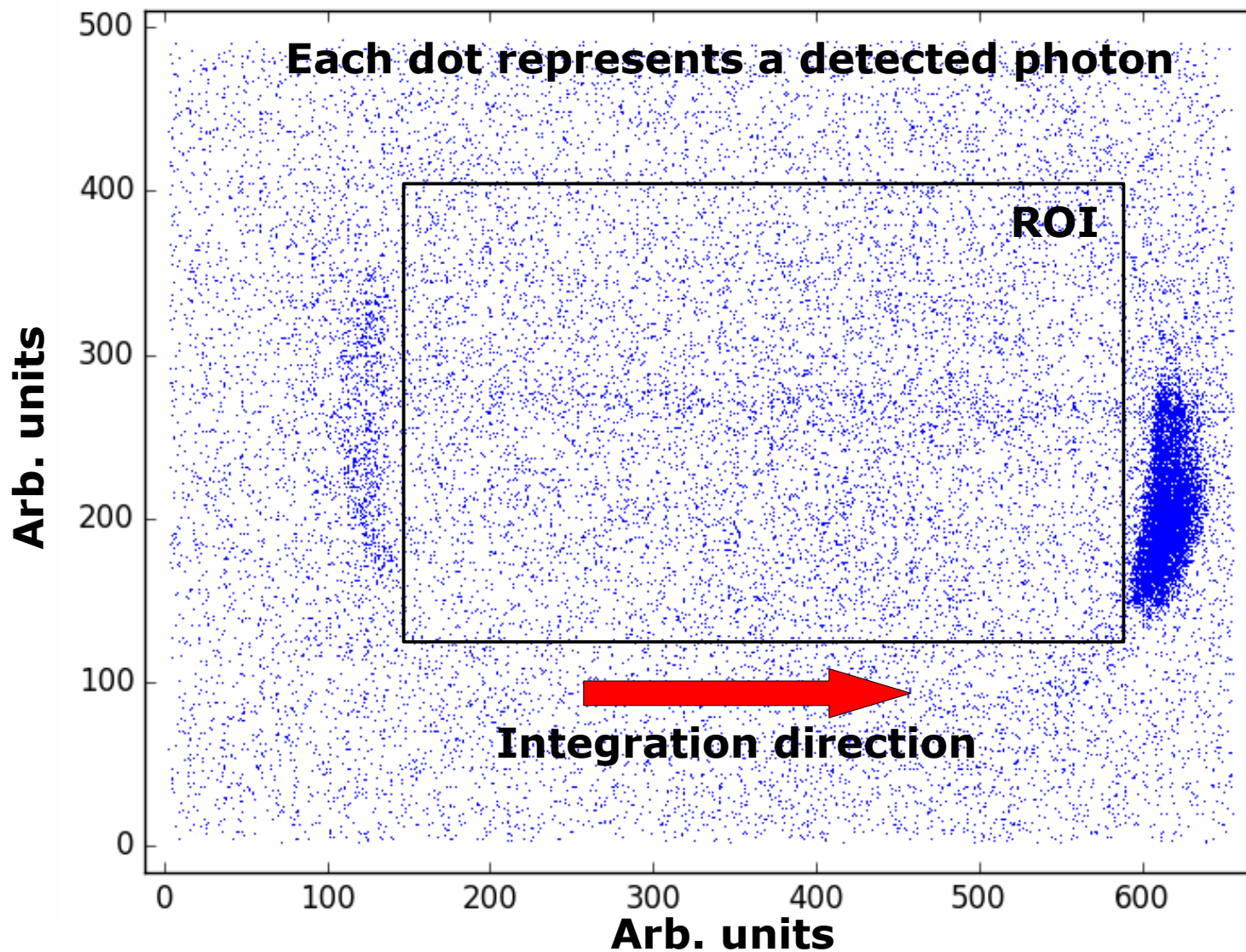
$$\Delta t_s(391, p^+) \approx 20 \text{ ms/photon}$$

$$\Delta t_s(391, e^-) \approx 0.7 \text{ ms/photon}$$

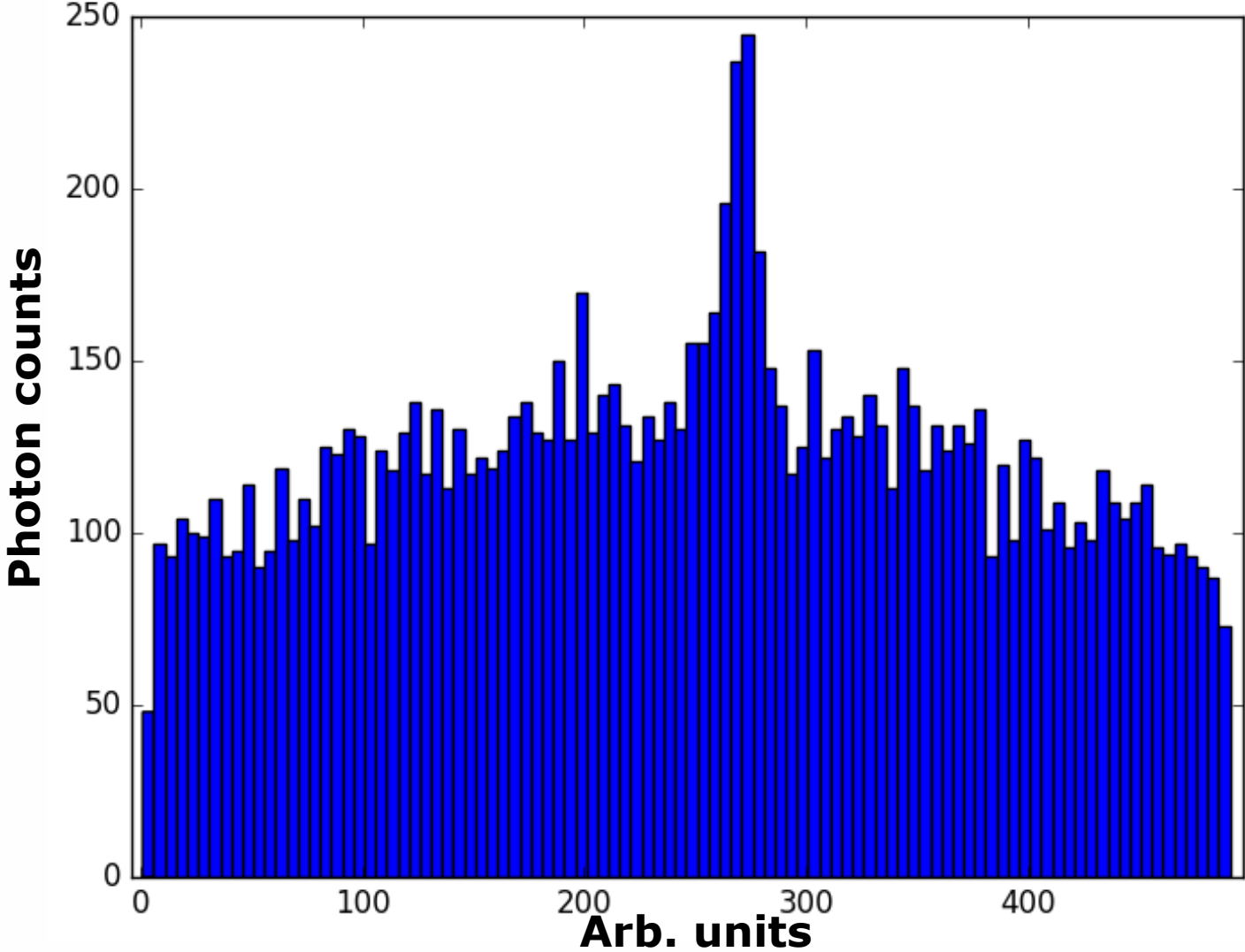
$$\Delta t_s(337, e^-) \approx 46 \text{ s/photon}$$

Note: For the present setup at the Cockcroft Institute the cross section @ 391 nm is twice as high, the solid angle at an f-ratio of 5.6 is as considered above but the electron current is approx. 10 μ A. This results in $\Delta t_s(391, e^-) \approx 35 \text{ s/photon}$.

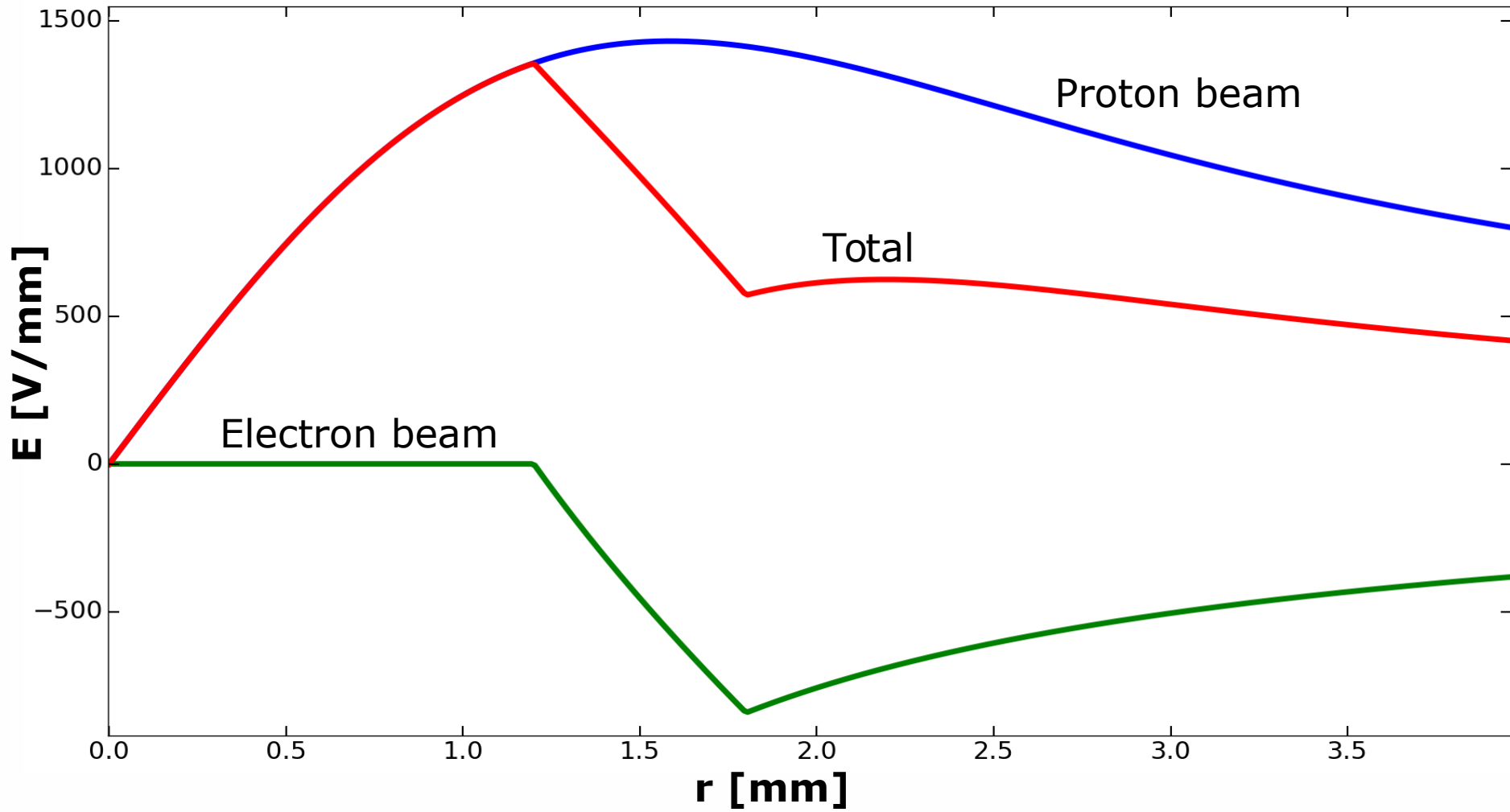
First signal at Cockroft (part 1)



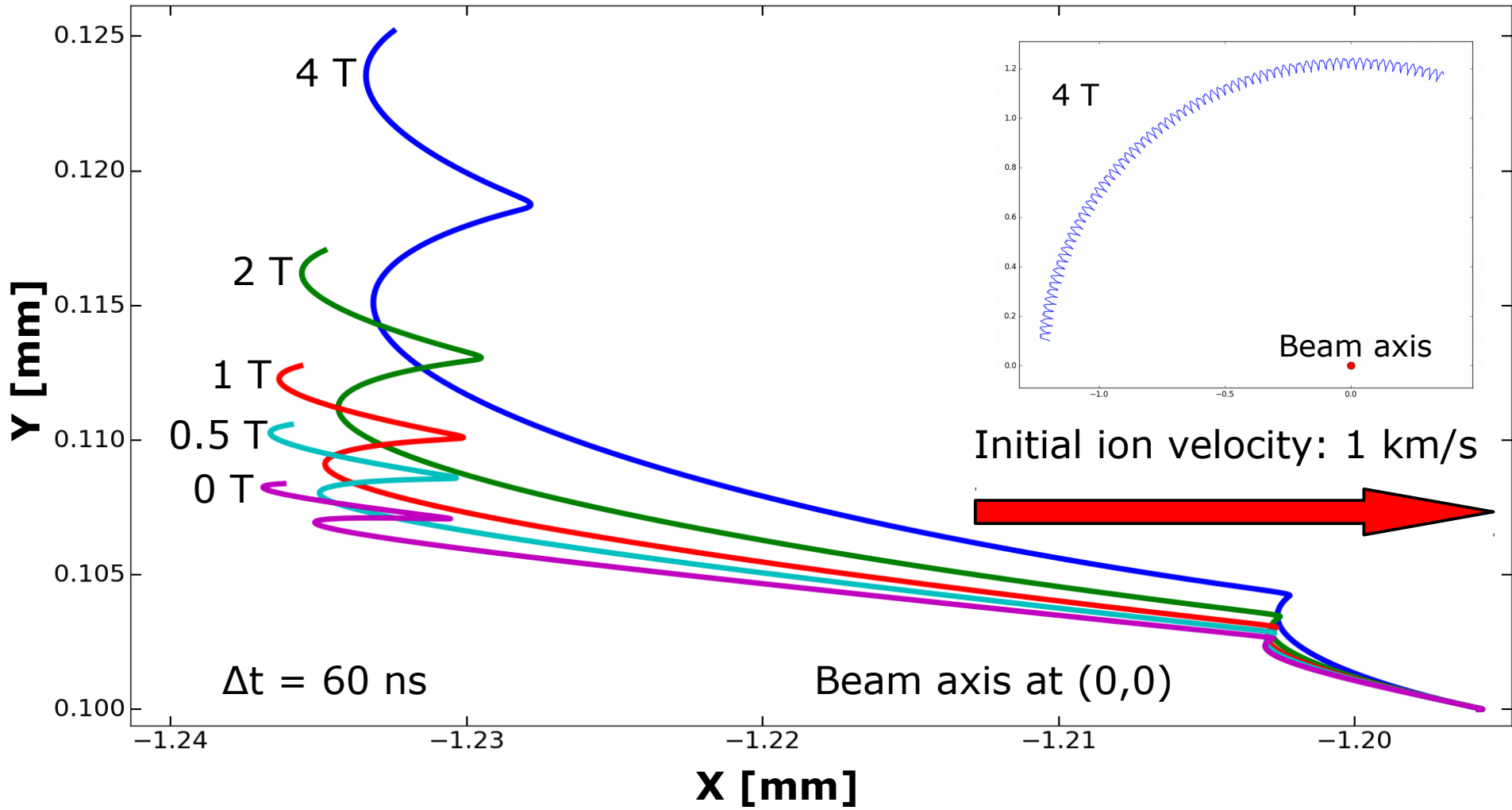
First signal at Cockroft (part 2)



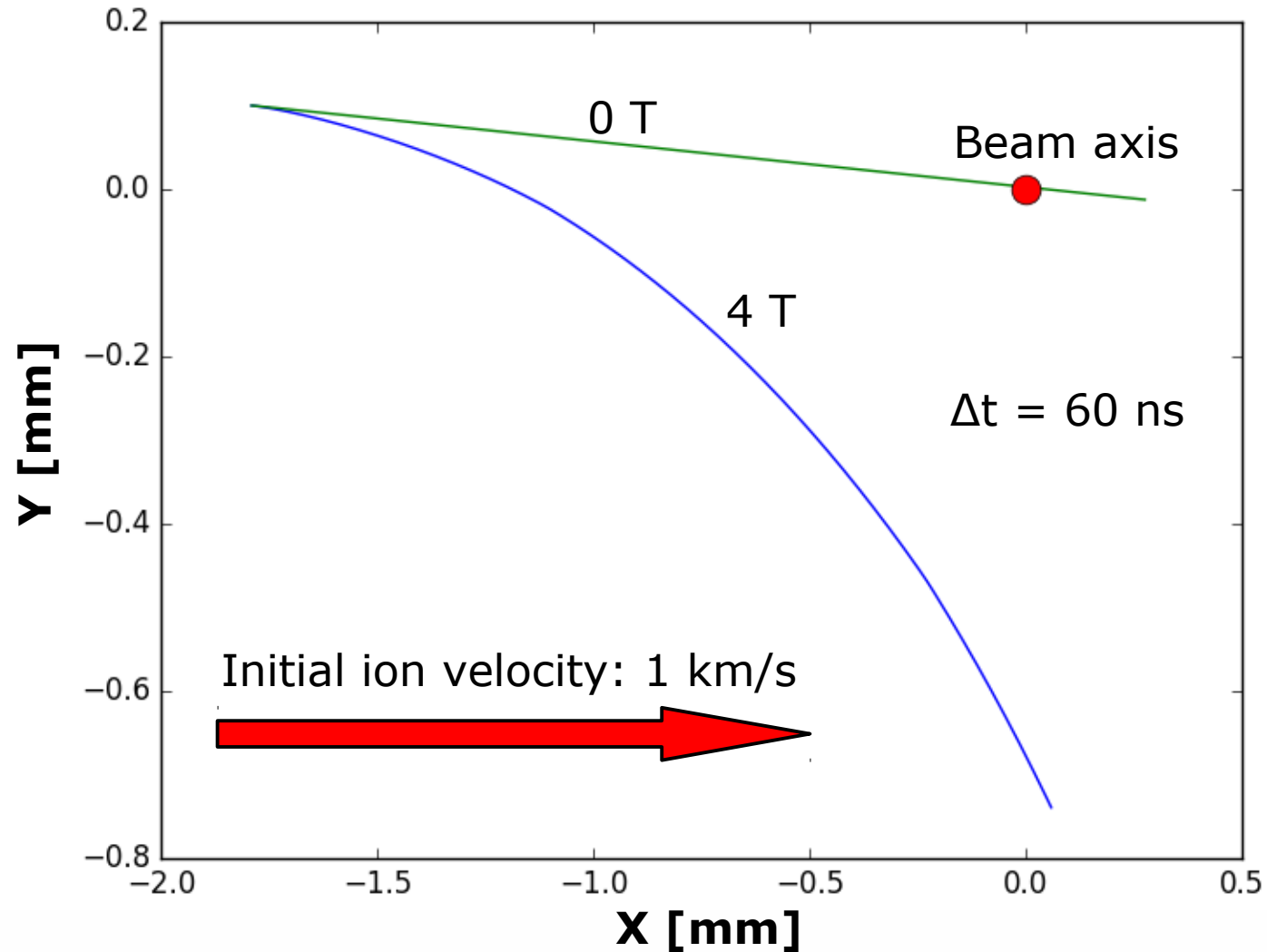
Ion and electron dynamics: electric field



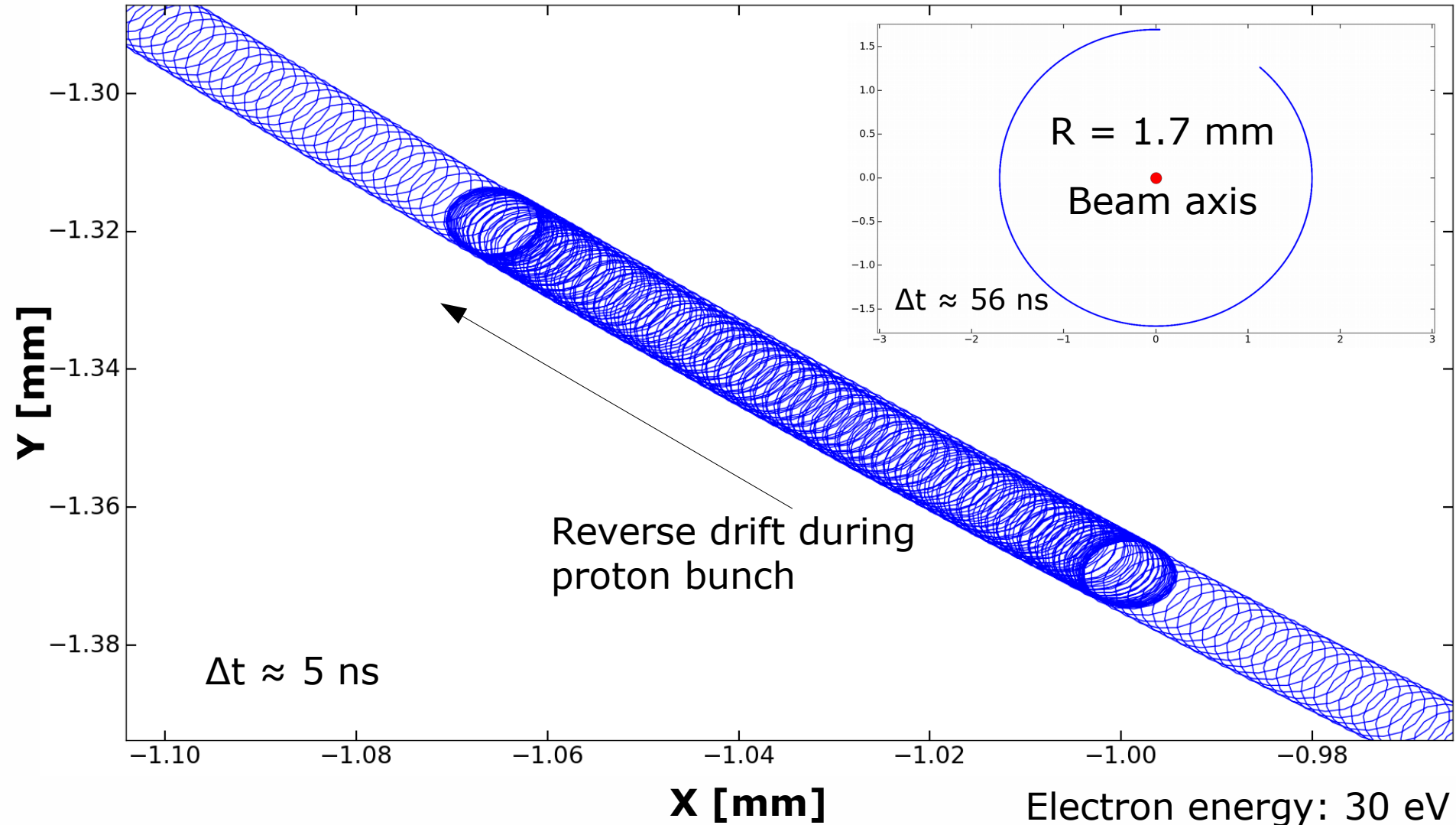
Ion and electron dynamics: N₂ ions (part 1)



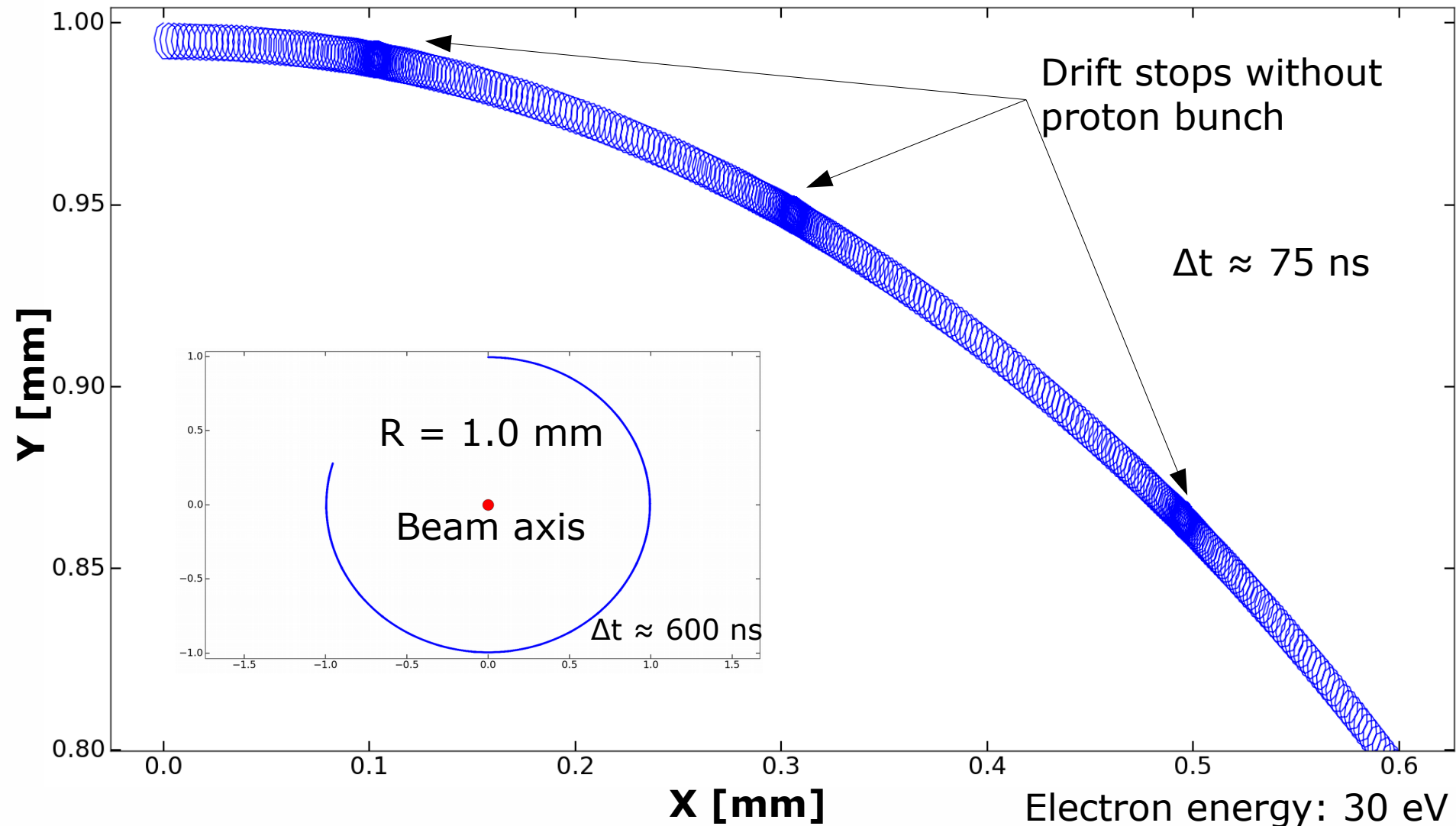
Ion and electron dynamics: N₂ ions (part 2)



Ion and electron dynamics: electrons (part 1)



Ion and electron dynamics: electrons (part 2)





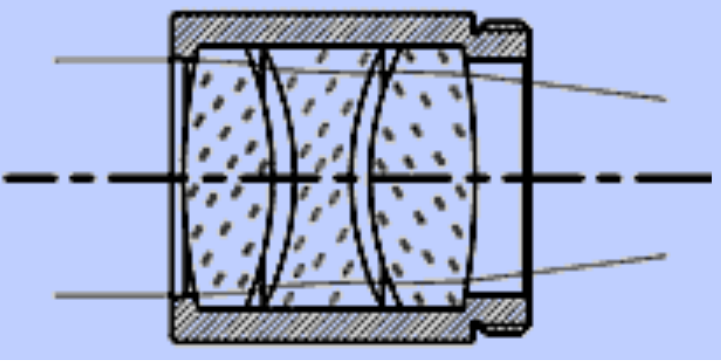
- Strong fluorescence due to neutrals
- Ne^+ fluorescence from levels with short life times (< 10 ns)
- Mass comparable with that of N_2
- Emission by neutrals at long wavelengths ($\lambda > 580$ nm); photocathodes with higher sensitivity in this region lead to a larger rate of dark counts
- Presently no known data about fluorescence cross sections due to relativistic protons
- Presently known data on cross sections for the interaction with electrons just for the neutral atom, no data regarding combined ionization and excitation

Optics: requirements



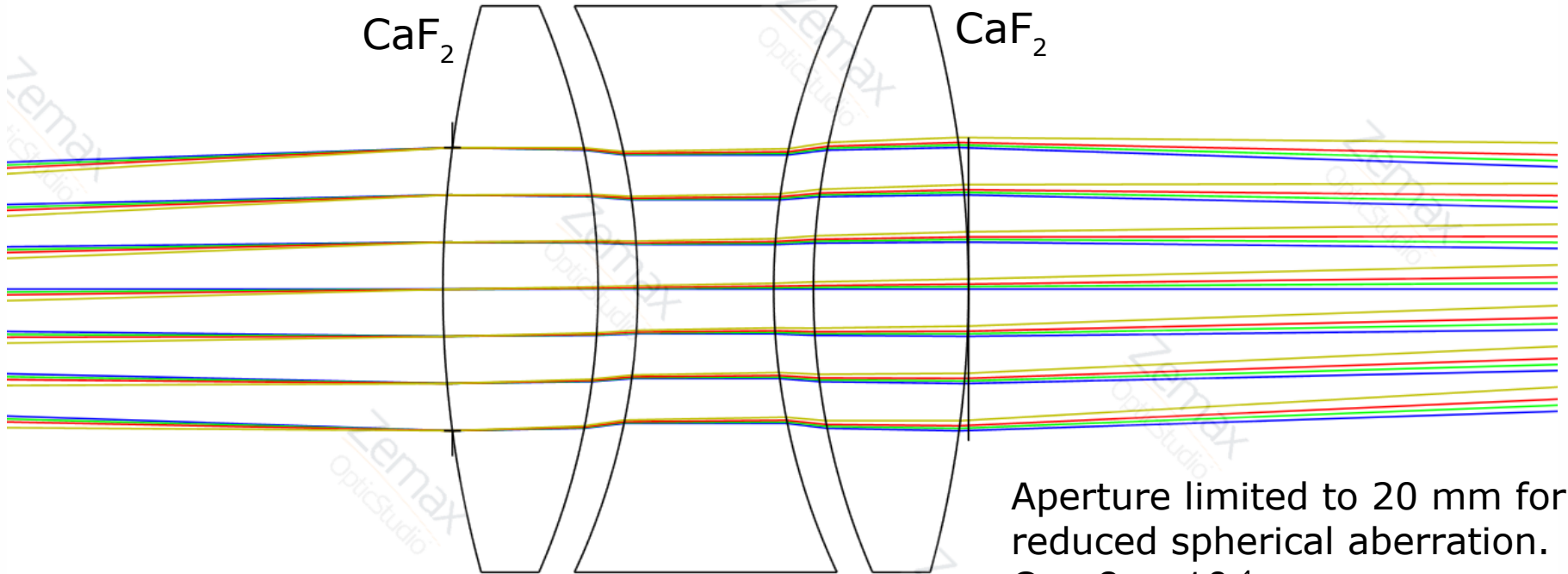
- Good transmission in the near UV, at least in the region 300 to 400 nm
- Good resolution, well corrected geometrical and chromatic aberrations
- A magnification of about 1 (absolute value) due to the relatively low resolution of the double MCP stack of at most 20 lp/mm
- Relatively large working distance allows the placement of the detector system at $d > 400$ mm from the beam axis
- Large acceptance, a solid angle of about $4\pi \cdot 10^{-4}$ sr desirable
- Total depth of field up to 15 mm with reasonable blur

Optics: commercially available lens (part 1)



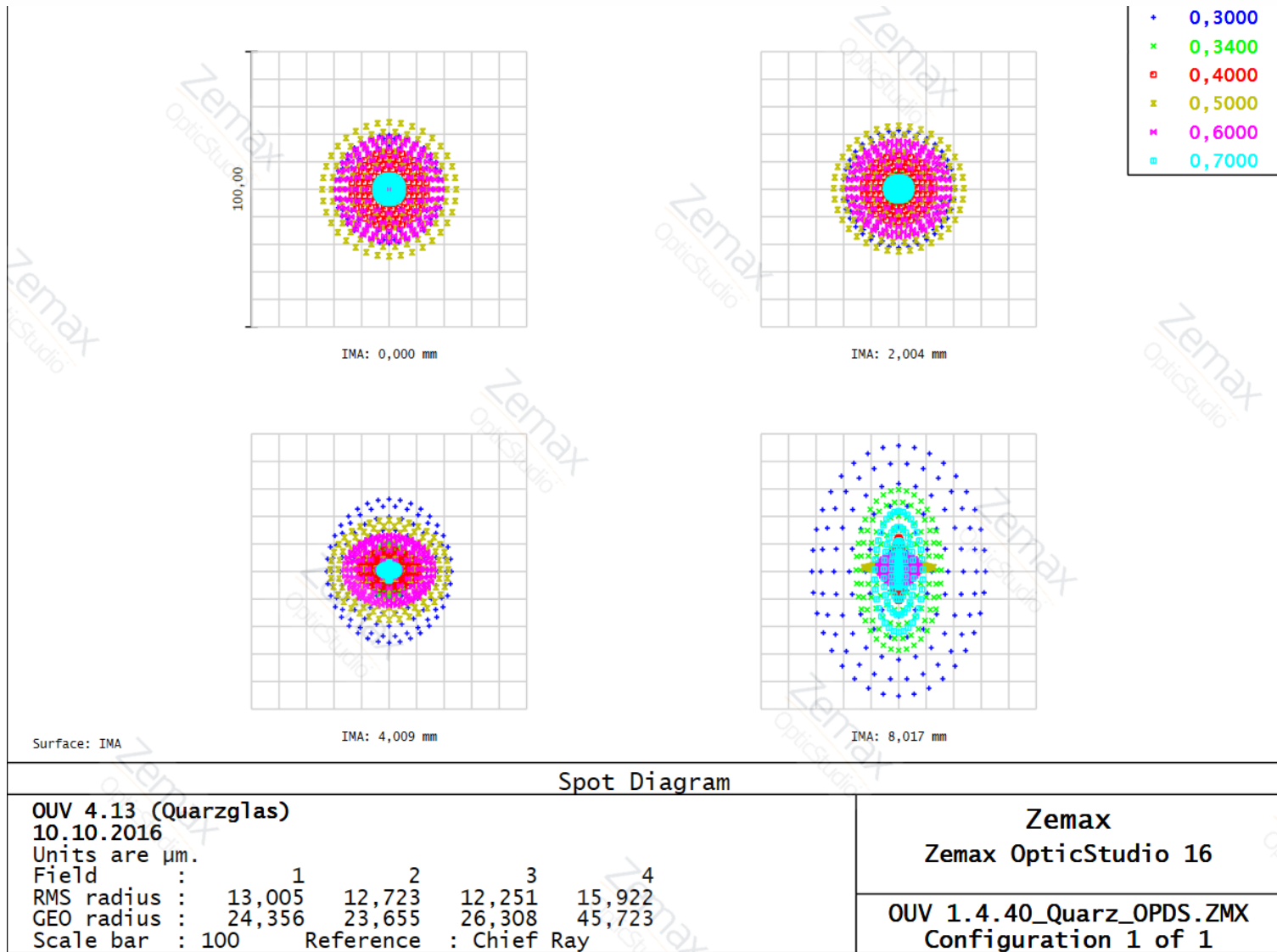
Optimized for 1:-1 imaging
Focal length (EFL): 160 mm
Maximum aperture: 40 mm
Mount diameter: 50 mm
Mount length: 54 mm
Thread: M48x1

CaF₂ Fused silica CaF₂

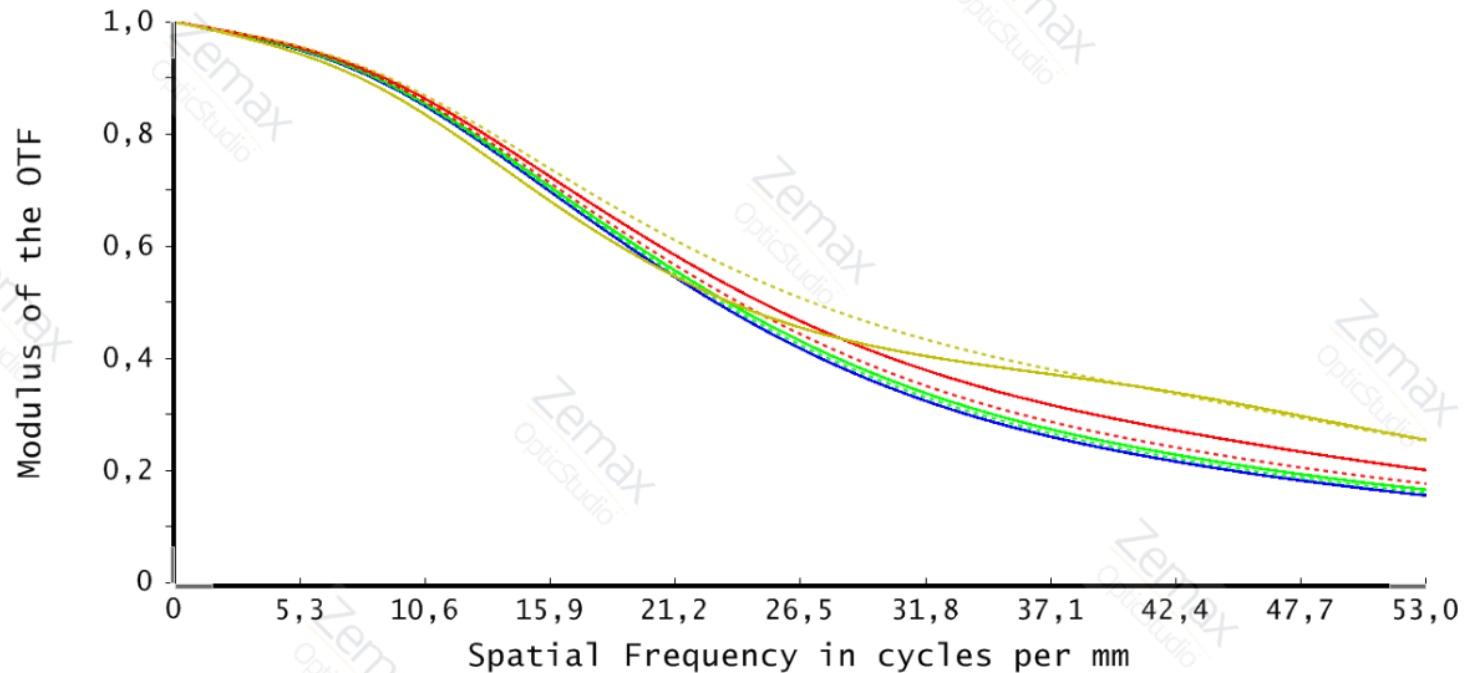


Aperture limited to 20 mm for reduced spherical aberration.
 $\Omega \approx 8\pi \cdot 10^{-4} \text{ sr}$

Optics: commercially available lens (part 2)



Optics: commercially available lens (part 3)



- 0,0000 mm-Tangential
- 0,0000 mm-Sagittal
- 2,0000 mm-Tangential
- 2,0000 mm-Sagittal
- 4,0000 mm-Tangential
- 4,0000 mm-Sagittal
- 8,0000 mm-Tangential
- 8,0000 mm-Sagittal

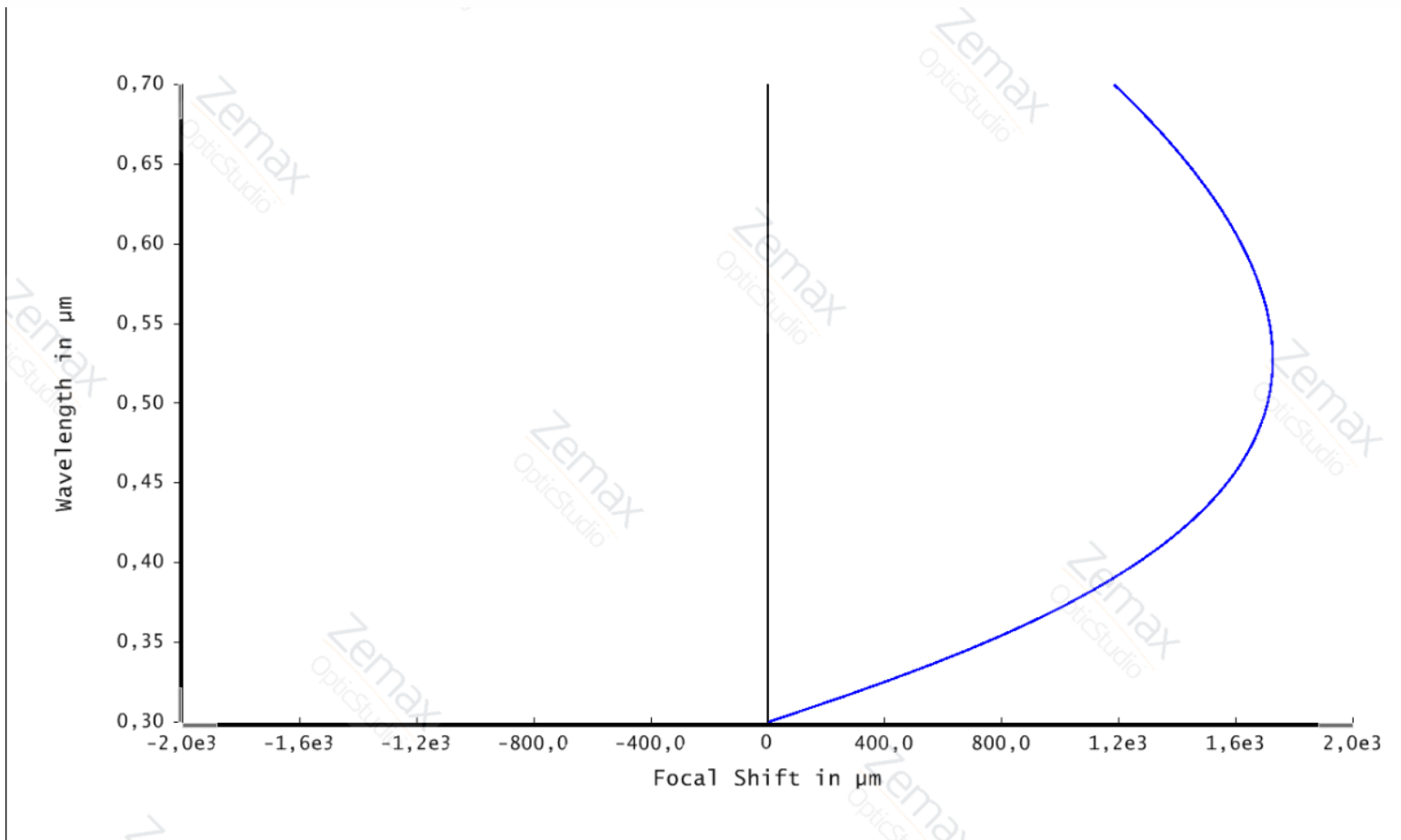
Polychromatic Diffraction MTF

OUV 4.13 (Quarzglas)
 10.10.2016
 Data for 0,3000 to 0,7000 μm .

Zemax
 Zemax OpticStudio 16

OUV 1.4.40_Quarz_OPDS.ZMX
 Configuration 1 of 1

Optics: commercially available lens (part 4)



Chromatic Focal Shift

OUV 4.13 (Quarzglas)
 10.10.2016
 Maximum Focal Shift Range: 1725,8544 μm
 Diffraction Limited Range: 283,263 μm
 Pupil Zone: 0,0000

Zemax
 Zemax OpticStudio 16

OUV 1.4.40_Quarz_OPDS.ZMX
 Configuration 1 of 1



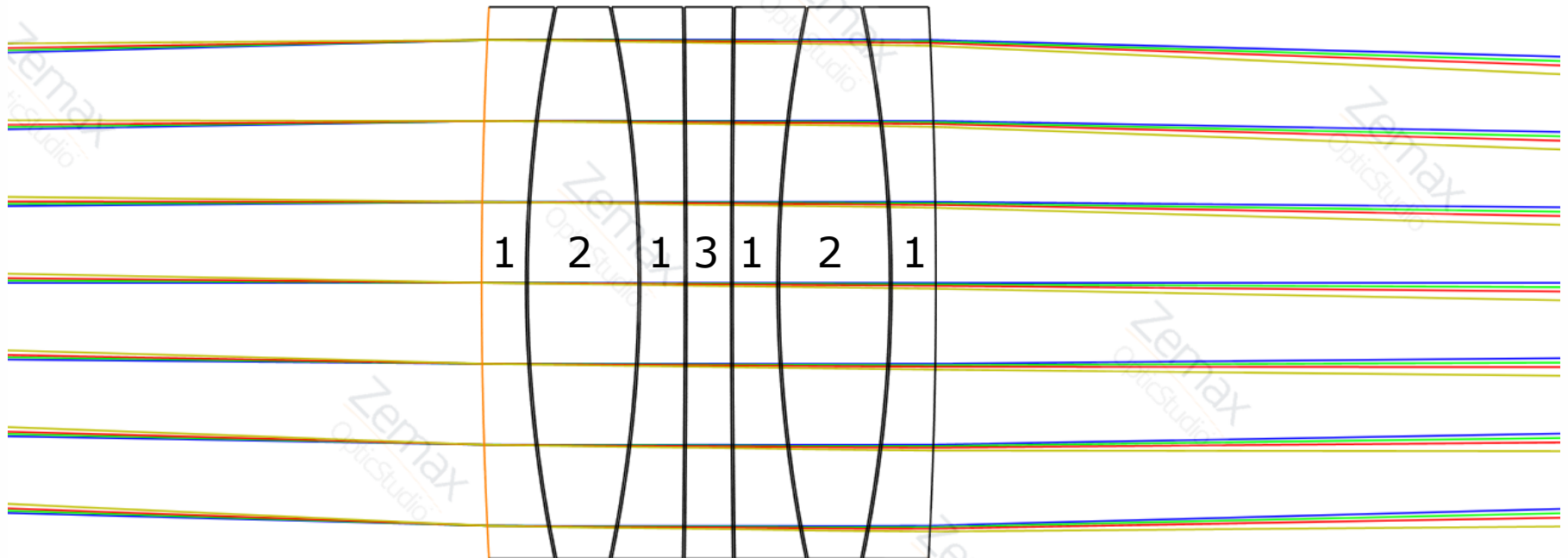
Optics: custom lens (part 1)



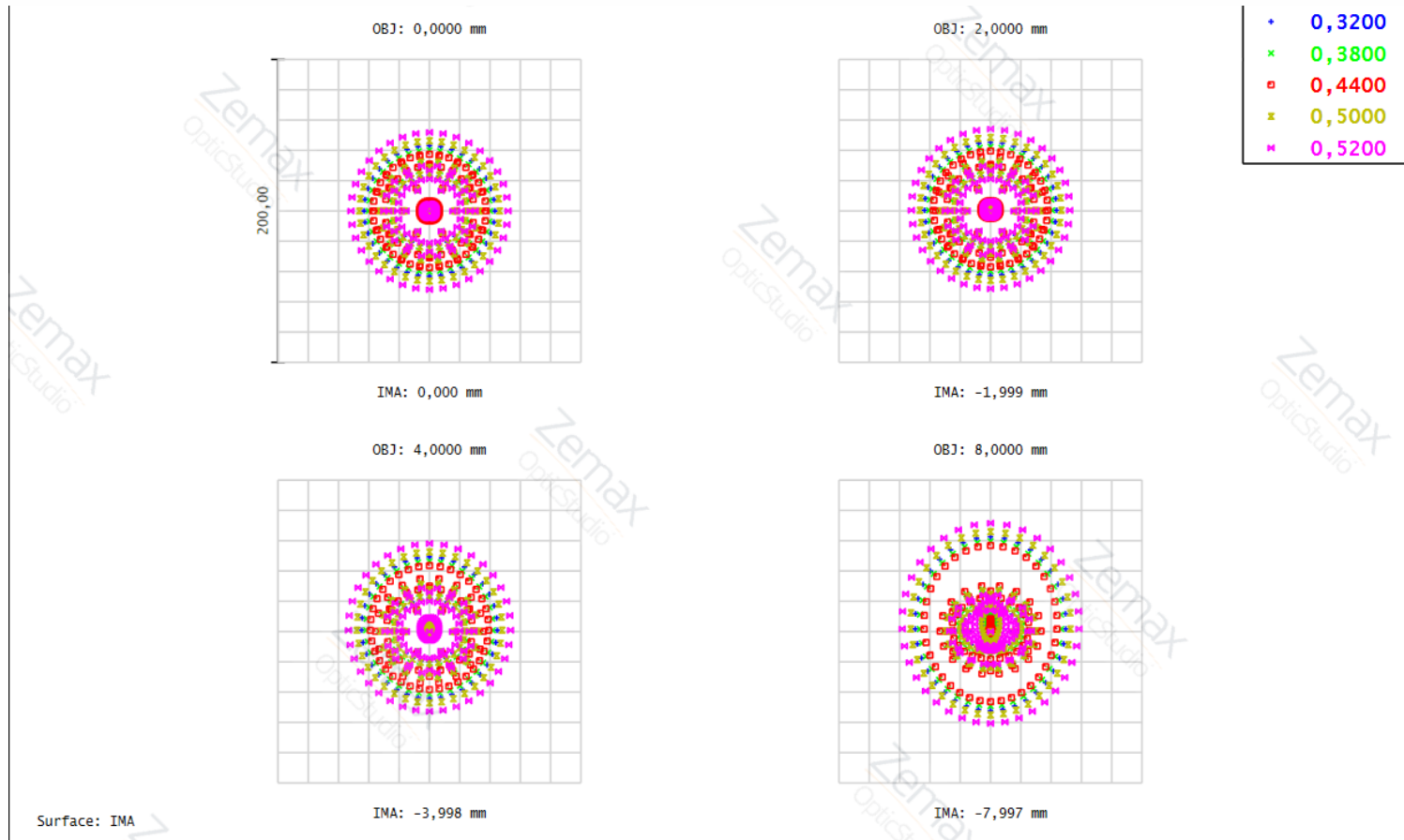
Optimized for low chromatic aberrations at short wavelengths and 1:-1 imaging
Transmission down to 310 nm
Geometric aberrations not yet corrected
Focal length (EFL): 210 mm
Maximum aperture: 22 mm
Lens diameter: 25 mm

Aperture limited to 22 mm
 $\Omega \approx 5\pi \cdot 10^{-4}$ sr

- 1 – Fused silica
- 2 – BaF₂
- 3 – LLF1HTi

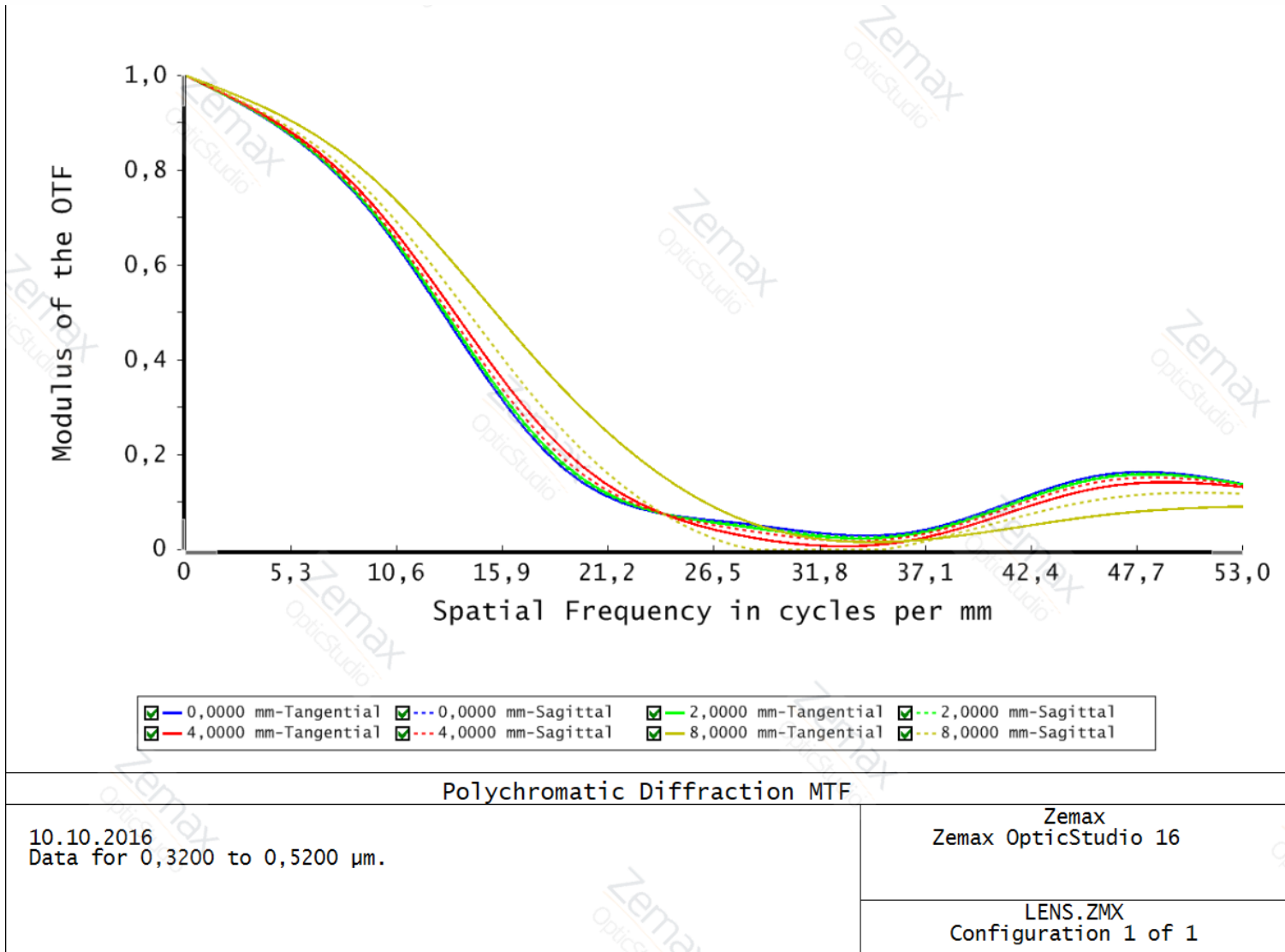


Optics: custom lens (part 2)

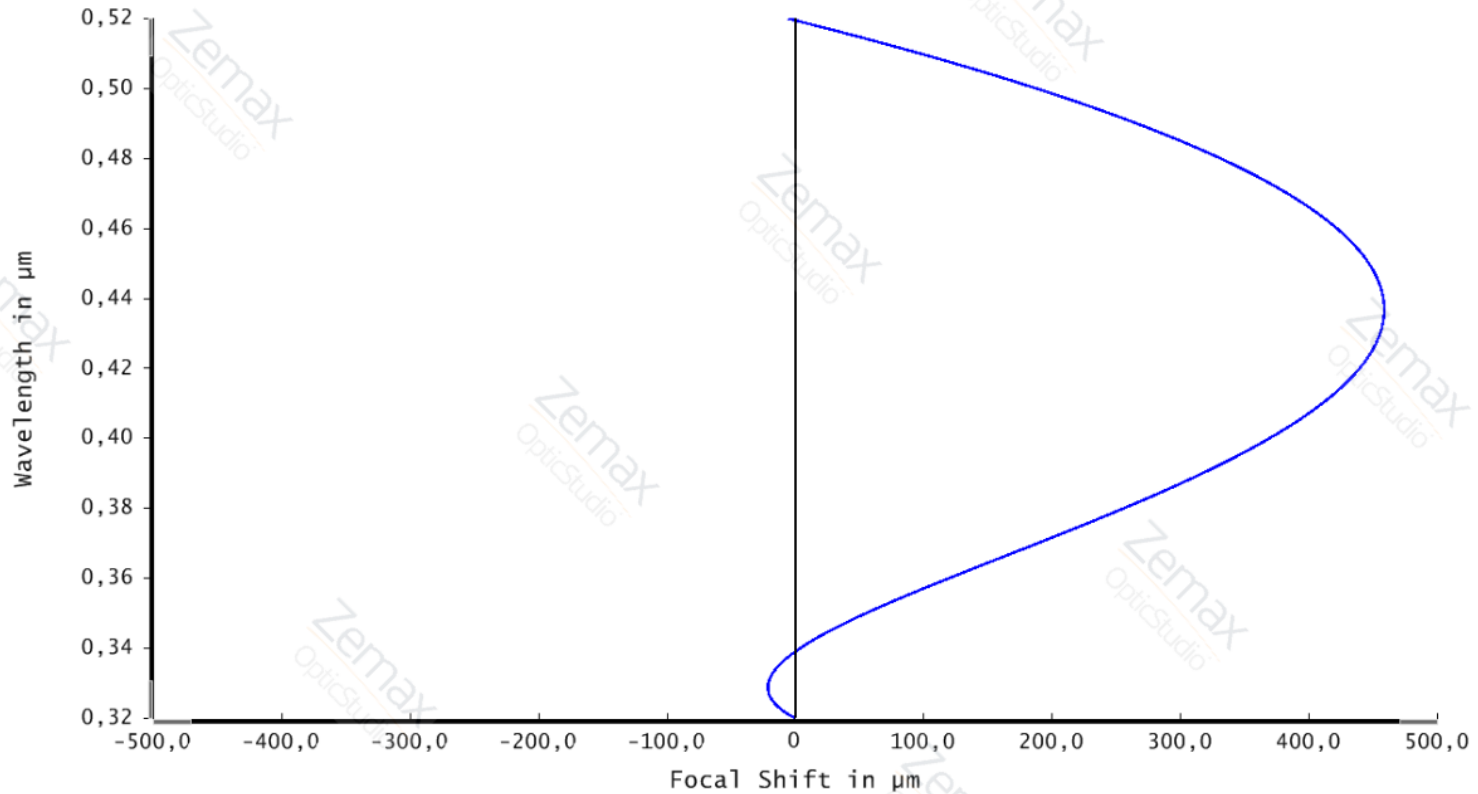


Spot Diagram					Zemax Zemax OpticStudio 16	
10.10.2016					LENS.ZMX	
Units are μm .					Configuration 1 of 1	
Field :	1	2	3	4		
RMS radius :	30,342	30,475	30,923	33,399		
GEO radius :	51,893	54,158	58,199	71,601		
Scale bar : 200	Reference :		Chief Ray			

Optics: custom lens (part 3)



Optics: custom lens (part 4)



Chromatic Focal Shift

10.10.2016
Maximum Focal Shift Range: 480,0726 μm
Diffraction Limited Range: 455,082 μm
Pupil Zone: 0,0000

Zemax
Zemax OpticStudio 16

LENS.ZMX
Configuration 1 of 1



Open questions



- Role of secondary electrons
- Cleaning electrodes for secondary electrons
- Radiation hardness and scintillation of optical materials
- Move to an optical system made exclusively of mirrors
- How to best distinguish between electron and proton beam
- Reasons for low signal at the Cockcroft Institute; acquisition of a better electron gun
- Use of another detector system: emCCD
- What are the priorities

Conclusions



- MCP based detector system is a good option
- Commercially available optics identified
- Alternative custom lens with promising characteristics
- Integration times in case of N₂ got estimated and are short enough for detection at 391 nm
- Setup at Cockroft delivered first signal from background gas